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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
09/838,316	04/20/2001	Zhiheng Lu	95153-0110	1839
20736	7590 10/21/2003		EXAMINER	
MANELLI DENISON & SELTER 2000 M STREET NW SUITE 700			CHEN, JACK S J	
	ON, DC 20036-3307		ART UNIT	. PAPER NUMBER
	·		2813	

DATE MAILED: 10/21/2003

Please find below and/or attached an Office communication concerning this application or proceeding.

.,	Application No.	Applicant(s)				
•	09/838,316	LU, ZHIHENG				
Office Action Summary	Examiner	Art Unit				
	Jack Chen	2813				
The MAILING DATE of this communication appears on the cover sheet with the correspondence addr ss Period for Reply						
A SHORTENED STATUTORY PERIOD FOR REPLY THE MAILING DATE OF THIS COMMUNICATION. - Extensions of time may be available under the provisions of 37 CFR 1.13 after SIX (6) MONTHS from the mailing date of this communication. - If the period for reply specified above is less than thirty (30) days, a reply - If NO period for reply is specified above, the maximum statutory period w - Failure to reply within the set or extended period for reply will, by statute, - Any reply received by the Office later than three months after the mailing earned patent term adjustment. See 37 CFR 1.704(b). Status	6(a). In no event, however, may a reply be tim within the statutory minimum of thirty (30) days ill apply and will expire SIX (6) MONTHS from cause the application to become ABANDONEI	ely filed s will be considered timely. the mailing date of this communication. O (35 U.S.C. § 133).				
1) Responsive to communication(s) filed on <u>Feb.</u>	27, 2003 through July 29, 2003					
2a)⊠ This action is FINAL . 2b)□ Thi	s action is non-final.					
3) Since this application is in condition for allowance except for formal matters, prosecution as to the merits is closed in accordance with the practice under <i>Ex parte Quayle</i> , 1935 C.D. 11, 453 O.G. 213. Disposition of Claims						
4)⊠ Claim(s) 1-18 and 21-33 is/are pending in the	application.					
4a) Of the above claim(s) 2,4-18 and 29-33 is/are withdrawn from consideration.						
5) Claim(s) is/are allowed.						
6)⊠ Claim(s) <u>1, 3, 21-28</u> is/are rejected.						
7) Claim(s) is/are objected to.	7) Claim(s) is/are objected to.					
8) Claim(s) are subject to restriction and/or election requirement.						
Application Papers						
9) The specification is objected to by the Examiner.						
10)☐ The drawing(s) filed on is/are: a)☐ accepted or b)☐ objected to by the Examiner.						
Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a).						
11)☐ The proposed drawing correction filed on is: a)☐ approved b)☐ disapproved by the Examiner.						
If approved, corrected drawings are required in reply to this Office action.						
12) The oath or declaration is objected to by the Examiner.						
Priority under 35 U.S.C. §§ 119 and 120						
13) Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f).						
a) All b) Some * c) None of:						
1. Certified copies of the priority documents						
2. Certified copies of the priority documents						
 3. Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)). * See the attached detailed Office action for a list of the certified copies not received. 						
14) Acknowledgment is made of a claim for domestic priority under 35 U.S.C. § 119(e) (to a provisional application).						
a) The translation of the foreign language provisional application has been received. 15) Acknowledgment is made of a claim for domestic priority under 35 U.S.C. §§ 120 and/or 121.						
Attachment(s)						
1) Notice of References Cited (PTO-892) 2) Notice of Draftsperson's Patent Drawing Review (PTO-948) 3) Information Disclosure Statement(s) (PTO-1449) Paper No(s) 6) Other:						
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DETAILED ACTION

1. In response to the communications dated February 27, 2003 through July 29, 2003, claims 1-18 and 21-33 are active in this application.

Claim Objections

2. Claims 1 is objected to because of the following informalities:

Regarding claim 1, line 12, the term "the said" should change to --said-- for formality.

Appropriate correction is required.

Claim Rejections - 35 USC § 112

- 3. The following is a quotation of the second paragraph of 35 U.S.C. 112:
 - The specification shall conclude with one or more claims particularly pointing out and distinctly claiming the subject matter which the applicant regards as his invention.
- 4. Claim 27 is rejected under 35 U.S.C. 112, second paragraph, as being indefinite for failing to particularly point out and distinctly claim the subject matter which applicant regards as the invention.

Regarding claim 27, line 3, the term "all the buried oxide layer" lacks antecedent basis.

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Claim Rejections - 35 USC § 102

5. The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the

basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless -

(b) the invention was patented or described in a printed publication in this or a foreign country or in public use

or on sale in this country, more than one year prior to the date of application for patent in the United States.

6. Claim 1 is rejected under 35 U.S.C. 102(b) as being anticipated by Griffith,

U.S./4,786,608.

Griffith discloses a method for forming a SOI material on a silicon containing substrate

having a major surface, which comprises implanting first kind of ions (oxygen ions, fig. 1) at a

first dose (1E18/cm2) and a first energy (150-200keV) through said major surface into said silicon

containing substrate 10 controlled at a first temperature (400 oC), see col. 3, line 60 to col. 4, line

29; implanting second kind of ions (silicon ions, fig. 2) at a second dose (0.5-2E15/cm2) and a

second energy (120-140keV) through said major surface into said silicon containing substrate at a

second temperature below 100 oC (room temperature), to form an amorphous region 22 (fig. 2)

beneath the major surface and to keep the original structure in the major surface of said silicon

containing the substrate (fig. 2, col. 4, lines 28-55, also see abstract and summary sections); and

annealing silicon containing substrate at a third temperature (in this case, at least the end point,

i.e., 1250 oC meets the claimed limitation; furthermore, it appears that there is nothing critical

about this temperature, 1250 oC) in the range from a temperature to below the melting point of

silicon, to form a buried layer 13/33 combining the first implanted ions with silicon in the

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substrate, and a top silicon layer including the said major surface isolated by the buried layer (figs. 3-4, cols. 4-5), wherein the amorphous region contains a majority of a top silicon layer and the whole buried layer (figs. 2-3), see figs. 1-4, cols. 1-8 for more details.

Claim Rejections - 35 USC § 103

- 7. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:
 - (a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.

This application currently names joint inventors. In considering patentability of the claims under 35 U.S.C. 103(a), the examiner presumes that the subject matter of the various claims was commonly owned at the time any inventions covered therein were made absent any evidence to the contrary. Applicant is advised of the obligation under 37 CFR 1.56 to point out the inventor and invention dates of each claim that was not commonly owned at the time a later invention was made in order for the examiner to consider the applicability of 35 U.S.C. 103© and potential 35 U.S.C. 102(e), (f) or (g) prior art under 35 U.S.C. 103(a).

8. Claims 3, 21-28 are rejected under 35 U.S.C. 103(a) as being unpatentable over Griffith, U.S./4,786,608 in view of Ogura, U.S./5,888,297.

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Griffith disclosed above in paragraph 6. However, Griffith is silent to use nitrogen ions as the first kind of ions.

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Ogura teaches a method for forming SOI, which comprises implanting first oxygen ions or nitrogen ion (fig. 2, abstract and summary sections) into the silicon substrate; and implanting second silicon ions into the silicon substrate (fig. 2, cols. 3-8).

Therefore, it would have been obvious to one having ordinary skill in the art at the time the invention was made to implanting nitrogen ions having the similar implanting energy, and dosage instead of implanting oxygen ions as taught by Ogura in the method of Griffith in order to form a buried nitride layer for the SOI. Furthermore, it would have been obvious to one having ordinary skill in the art at the time the invention was made to modify the method of Griffith by selecting the suitable implanting energy, dosage and temperature, since it has been held that where the general conditions of a claim are disclosed in the prior art, discovering the optimum or workable ranges involves only routine skill in the art. In re Aller, 220 F.2d 454, 456, 105 USPQ 233, 235 (CCPA 1955).

Regarding claim 3, Ogura shows the first kind of ions is nitrogen ions, so as to form the buried layer as a buried nitride layer.

Regarding claim 21, Griffith (1E18/cm2) and Ogura (2E17/cm2) both show the first dose is in the range from 1E16-5E18/cm2.

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Regarding claim 22, Griffith (150-200keV) and Ogura (60keV) both show the first energy is chosen to form enough depth of the buried layer after the annealing process, so as to form a desired thickness of the top silicon layer.

Regarding claim 23, Griffith (150-200keV) and Ogura (60keV) both show the first energy is in the range from 50-400keV.

Regarding claim 24, Griffith (500-600 oC) shows the first temperature is chosen to keep the original structure in vicinity of the major surface on silicon containing substrate in the first implantation process step.

Regarding claim 25, Griffith (500-600 oC) shows the first temperature is in the range from 450-700 oC.

Regarding claim 26, Griffith (120-140keV) and Ogura (150keV) both show the second energy is chosen in the range from 30keV to 5MeV to form an amorphous region beneath the major surface and to keep the original structure in the major surface of the silicon containing structure during the second implantation step.

Regarding claim 27, Griffith (0.5-2E15/cm2) and Ogura (8E15/cm2) both show the second dose is chosen in the range from 1E13-5E16/cm2 to form an amorphous region beneath the major surface containing both a majority of top silicon layer and all the buried layer, which is formed in the annealing step.

Regarding claim 28, Griffith (fig. 2) and Ogura (fig. 2) both show the second kind of ion is silicon ion.

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Conclusion |

9. THIS ACTION IS MADE FINAL. Applicant is reminded of the extension of time policy as set forth in 37 CFR 1.136(a).

A shortened statutory period for reply to this final action is set to expire THREE MONTHS from the mailing date of this action. In the event a first reply is filed within TWO MONTHS of the mailing date of this final action and the advisory action is not mailed until after the end of the THREE-MONTH shortened statutory period, then the shortened statutory period will expire on the date the advisory action is mailed, and any extension fee pursuant to 37 CFR 1.136(a) will be calculated from the mailing date of the advisory action. In no event, however, will the statutory period for reply expire later than SIX MONTHS from the mailing date of this final action.

10. Any inquiry concerning this communication or earlier communications from the examiner should be directed to Jack Chen whose telephone number is (703) 308-5838. The examiner can normally be reached on Monday-Friday (alternate Monday off) from 8:30 am to 6:00 pm.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Carl Whitehead, Jr., can be reached on (703)308-4940. The fax phone numbers for the organization where this application or proceeding is assigned are 703-872-9318 for regular communications and 703-872-9319 for After Final communications.

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Any inquiry of a general nature or relating to the status of this application or proceeding should be directed to the receptionist whose telephone number is (703)308-0956.

Jack Chen

Primary Examiner

October 20, 2003